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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Daniel Yellin Et Al. § Group Art Unit: 2634
Serial No.: 10/039,072 § Examiner: Cicely Q. Ware
Filed: January 2, 2002 § Atty. Dkt. No.: ITL.0613US
For: Robust Low Complexity Multi- § Assignee: Intel Corporation
Antenna Adative Minimum mean
Square Error Equalizer §

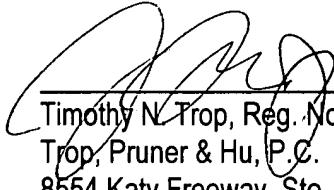
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicant submits the references listed on the attached form PTO 1449, copies of which are enclosed. A copy of a communication dated December 13, 2005 from a foreign patent office in a counterpart application is also enclosed. I, the undersigned, hereby certify that each item of information contained in the Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement. Please apply any charges or credits to Deposit Account No. 20-1504 (ITL.0613US).

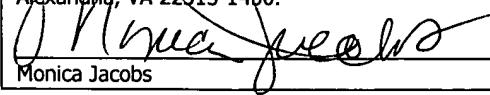
Respectfully submitted,

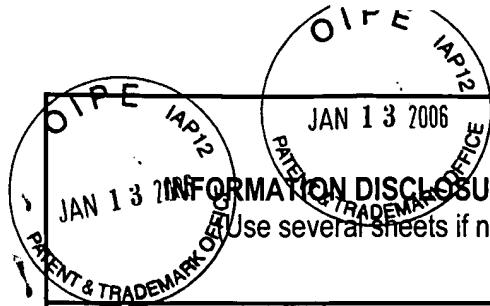


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Date of Deposit: January 9, 2006
I hereby certify under 37 CFR 1.8(a) that this correspondence is
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Monica Jacobs



JAN 13 2006

INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)ATTY DOCKET NO.
ITL.0613US (P11754)SERIAL NO.
10/039,072APPLICANT(S):
DANIEL YELLIN ET AL.FILING DATE:
January 2, 2002GROUP ART UNIT:
2634

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
A.	5,852,630	12/22/1998	LANGBERG ET AL.			
B.						
C.						
D.						
E.						
F.						
G.						
H.						
I.						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
J.							
K.							
L.							
M.							
N.							
O.							
P.							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Q.	
R.	
S.	
T.	
U.	
V.	
W.	

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.